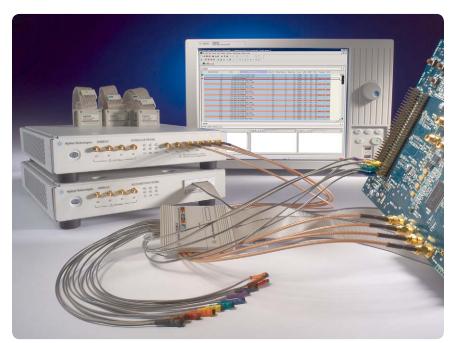


# Agilent MIPI D-PHY Protocol Test Solutions N4851A/B MIPI D-PHY Acquisition Probe N4861A/B MIPI D-PHY Stimulus Probe

Data Sheet

- Accelerate your MIPI D-PHY test development
- Simplify your MIPI D-PHY test environment by combining stimulus and analysis



#### **Applications**

- MIPI D-PHY hardware prototype turn-on and debug
- System integration of embedded controller with MIPI D-PHY display and camera devices
- Troubleshooting interoperability issues
- · Robustness test with error injection
- Software debug of MIPI D-PHY-based systems

#### **Key features**

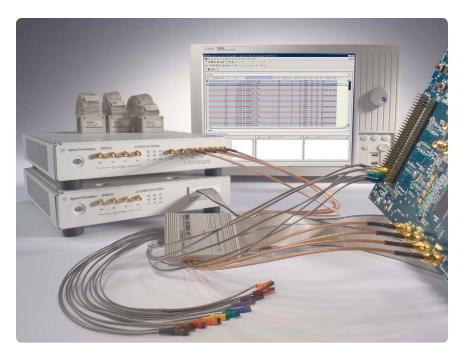
- Combined MIPI D-PHY real-time analysis and stimulus test solution
- Real-time trace of MIPI D-PHY bus modes
- Decoding and visualization of CSI-2 and DSI protocols
- Easy trigger setup with predefined pattern library
- Hierarchical trace display capabilities

- Automatic stimulus generation from bitmap picture
- · Full custom traffic generation
- · Capture and replay capabilities
- Link layer test with parametric control of voltages and timing
- Based on a modular, scalable, logic analyzer platform for multi-bus, system-level measurements
- Multilevel trigger sequencer to trigger the analyzer on complex event conditions



#### N4851A/B and N4861A/B MIPI D-PHY Analysis and Stimulus Test

# Combine custom traffic generation and real-time analysis to diagnose and characterize your system faster



MIPI D-PHY is a packet-based interconnect standard defined for use in wireless mobile devices as the communication bus between the main components such as the embedded controller (BB-IC) and cameras and displays.

When you adopt the MIPI D-PHY standard in your designs, you will face new test challenges during the debug, integration and system validation phases of the development process.

To ensure your design operates according to the MIPI D-PHY link and CSI-2 or DSI protocol specification, you need real-time insight on the DUT's behavior at various protocol levels, and you need to be able to trigger on protocol-specific patterns or error conditions.

To reproduce system problems or run non-regression tests, you often need to create traffic conditions that may be difficult to reproduce with real devices. The MIPI D-PHY stimulus solution can accelerate your design/debug/test cycle by reproducing these conditions.

The specific nature and operation modes of the MIPI D-PHY serial interconnect makes it extremely difficult to analyze or to stimulate with general-purpose test instruments.

Now you can get the capabilities you need with the N4851A/B and N4861A/B analysis and stimulus solution.

The Agilent Technologies N4851A/B acquisition probe and the N4861A/B stimulus probe operate in conjunction with Agilent 16800 and 16900 Series logic analyzers to provide the digital serial stimulus and acquisition capabilities required to independently debug and test a MIPI D-PHY component, or integrate your MIPI D-PHY-based mobile designs.

Thanks to the modular and scalable architecture of Agilent 16800 and 16900 logic analyzers, the MIPI D-PHY analysis and stimulus measurements can be time-correlated with other measurements (control logic, other serial buses, memory) on the device under test, helping you perform system-level measurements.

Cross triggering capabilities help you observe the activity on a bus when a specific event happens on another bus, helping you find the root cause of complex system-level problems.

With this versatile architecture, you can use the same platform from the bus design phase to system-level test, so you reduce your expenditure on test equipment.

This common, scalable system for protocol analysis and traffic generation protects your financial investment for years to come.

#### **Typical Configurations**

# MIPI D-PHY analysis configuration

- In analysis-only mode, the N4851A/B transparently captures traffic between two devices.
- Link activity and protocol operation (CSI, DSI) is captured through various probing solutions, from flying leads to soft-touch connectors.
- The analyzer includes a multilevel sequencer to trigger the analyzer on complex event conditions.
- Multiple analyzers can be synchronized and cross triggered for system-level measurements.

# MIPI D-PHY stimulus and analysis solution

- In active test mode (stimulus + analysis), a customizable stimulus is sent to the DUT, with simultaneous analysis of the response.
- The stimulus solution can be used to test peripherals, such as display devices, by simulating a system controller.
- Stimulus patterns can be defined in multiple ways:
  - File-based stimulus
  - GUI-based stimulus
  - · Record and play pattern
  - Bitmap-based Stimulus



Flying leads signal probing solution



N4851A/B MIPI D-PHY acquisition probe



N4861A/B MIPI D-PHY stimulus probe



Soft touch connectorless probes reduce cost and shorten your design cycle by eliminating probing connectors

#### N4851A/B Protocol Analysis Gives You Fast Insight into Your System

# Flexible GUI gives you easy visibility into MIPI D-PHY activity and system operation

 Bus mode operation, CSI-2 and DSI traffic, and trigger status are simultaneously displayed

# Hierarchical trace display speeds your debug process

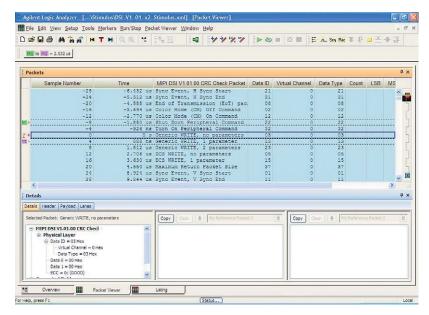
- Avoid constant scrollings with the hierarchical display that maximizes information density on the screen
- DSI and CSI-2 decoding capabilities for camera and display traffic analysis
- Compare frames details and easily find bit-level differences
- Easily retrieve information with embedded markers
- Quickly find problems with automatic error detection

#### Powerful triggering, easy setup

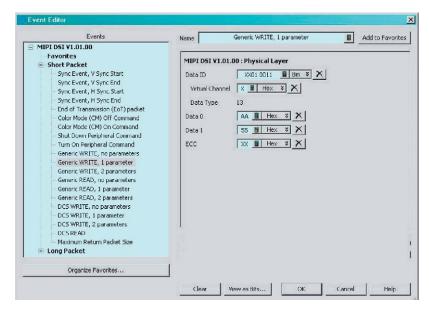
 Easy trigger setup by using and editing predefined patterns from the pattern library

# Multi-bus display for better insight into your system

- Traces captured from multiple buses are displayed with time-correlated time-stamps and common markers
- Multiple analyzers can share events for sophisticated cross triggering



MIPI D-PHY packet viewer



Trigger window

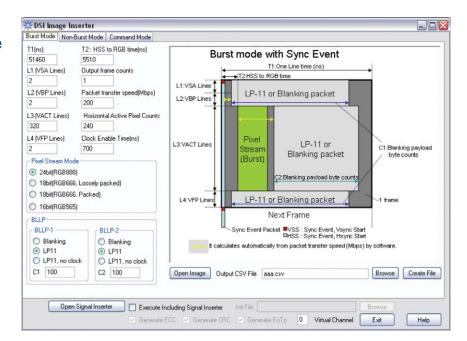
#### Image Inserter and Image Extractor Applications

# Quickly build MIPI DSI stimulus from bitmap files with the Image Inserter application

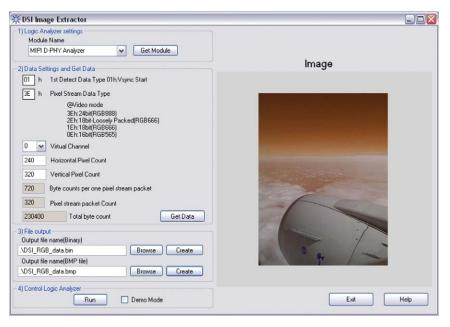
- Save hours of development and editing
- Configurable formats, bitmap encoding
- · Multiframe generation
- · Virtual channel support
- Supports burst mode, non-burst mode, command mode
- · Supports initialization commands

#### Visualize bitmaps from real time trace files with the Image Extractor application

- · Reconstruct picture from DSI trace
- · Virtual channel support
- Multiple frame support



DSI Image Inserter



DSI Image Extractor

## Agilent N4851A/B Analysis Probe — Features and Specifications

Electrical characteristics	
Voltage level support	D-PHY compliant
LPVhigh	800 mV to 3.3 V
Voltage sensitivity	100 mV typical
Track changes in speed mode	Yes - Mode changes displayed on trace
Termination	Analyzer probe snoops the bus (is not an endpoint on the bus) Termination is dependent on the actual endpoint device
Lane width	2 channels (N4851A), 4 channels (N4851B)
Maximum bit rate (high-speed mode)	800 Mbps (N4851A), 940 Mbps (N4851B)
Minimum bit rate (high-speed mode)	80 Mbps, per D-PHY specification
Maximum bit rate (low-power mode)	10 Mbps, per D-PHY specification
Minimum bit rate (low-power mode)	N/A ( no specification )
Protocol version support and decoding	
MIPI D-PHY DSI 1.01	Yes
MIPI D-PHY DSI 1.00	No
MIPI D-PHY CSI-2 1.00	Yes

Protocol viewing	
Protocol viewer	Hierarchical packet-level display
Protocol decoder	
HS and LP data support	Yes
Short and long packet decode	Yes
CSI and DSI decode	Yes
Decode speed changes	Yes
Payload viewing	Yes
Error decode	
SOT error display	Yes
EOT error display	Yes
Escape error display	Yes
Sequence error display	Yes
Turnaround error display	Yes
ECC, CRC error display	Yes
Contention detection	No

## Agilent N4851A/B Analysis Probe — Features and Specifications (continued)

Triggering capabilities	
Trigger on protocol patterns	Yes, on both DSI and CSI long and short patterns
Protocol pattern customization	Yes, with bit-level editing
Real-time error detection	
SOT error trigger	Yes, on a per lane basis
EOT error trigger	Yes, on a per lane basis
Escape error trigger	Yes, on a per lane basis
Sequence error trigger	Yes, on a per lane basis
Turnaround error trigger	Yes, on a per lane basis

Display	
Low power state of data transmission	Yes
Ultra-low power state	Not visible in the trace
Stopped	Yes

# N4861A/B Stimulus Probe Helps You Characterize Your System's Operation under Multiple Traffic Conditions

# Increase test coverage with configurable traffic generation

- Configurable traffic can be generated from the GUI, or from CSV files and bitmap files
- Deterministic D-PHY, DSI, CSI-2 pattern generation
- Customize the initialization sequence independently from the main test sequence
- · Repetitive events
- · 1, 2 or 3 channels support
- · Stimulus up to 1 Gbps

# Test your device's link layer and protocol layer

- Custom D-PHY bus mode transitions and link event generation
- · Test low-power bus mode
- · Custom DSI, CSI-2 traffic generation

# Validate boundary conditions of your devices and components

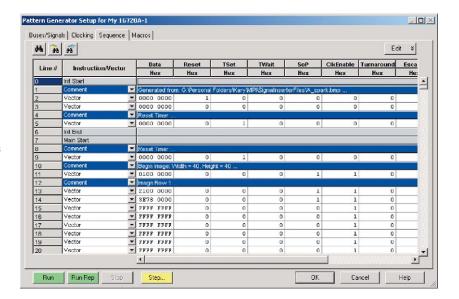
- Timing control of MIPI D-PHY link layer events within or outside specifications
- Voltage control of MIPI D-PHY signals
- Manual control of error generation helps you test robustness and error recovery mechanisms

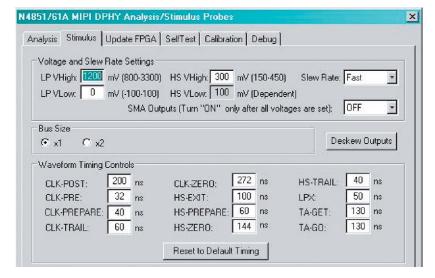
#### Record and play capabilities help you reproduce test scenarios from captured traces

- Use a wide range of specific realworld traffic conditions
- Save trace captured on a real target and replay it as many times as you want

# Increase test coverage with configurable traffic generation

 Generate traffic for multiple ports and correlate the test results across time for comprehensive system testing





Timing and voltage control of MIPI D-PHY stimulus

# Agilent N4861A/B Stimulus Probe — Features and Specifications

Electrical characteristics	LSR features
Lane width	2 channels (N4861A), 3 channels (N4861B)
Voltage level support	D-PHY compliant
Low-power voltage high adjustment	800 mV -> 3.3. V
Low-power voltage low adjustment	-100 mV -> +100 mV
High-speed voltage high adjustment	+150 mV -> +450 mV
High-speed voltage low adjustment	Not adjusted independently (changes with LPVlow or HSVhigh) Range is –17 mV to 217 mV
Slew rate control	Meets D-PHY specification in fast mode Fast, medium, slow, slowest
Mode change support	Yes
Waveform timing control CLK-POST timing control CLK-PRE timing control CLK-PREPARE timing control CLK-TRAIL timing control CLK-ZERO timing control HS-EXIT timing control HS-PREPARE HS-Zero HS-TRAIL LPX TA_Get TA_GO CLK lane and data lane skew adjust	Yes, automatic or manual settings No, under investigation
Device under test termination Expected DUT HS termination Expected DUT LP termination  Stimulus probe termination (no termination switching provided)	100-ohm differential termination None Either driver or tri-state (master only)
Clock input Data rate below 200 Mbps Data rate at or above 200 Mbps	Required for stimulus probe operation  Clock input = 1/2 bit rate  Clock input = 1/10 bit rate

## Agilent N4861A/B Stimulus Probe — Features and Specifications (continued)

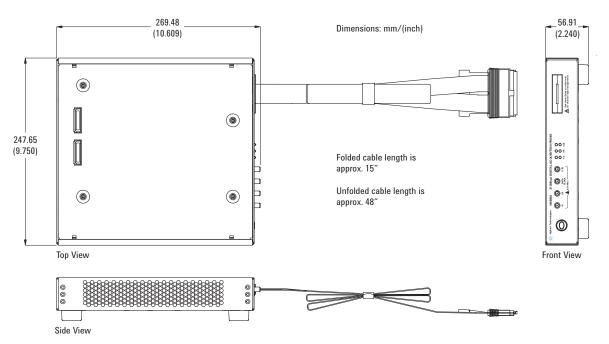
Performance – the numbers below	are guaranteed to comply to D-PHY's specifications
Maximum bit rate (high-speed mode)	500 Mbps (N4861A), 1 Gbps (N4861B)
Minimum bit rate (high-speed mode)	80 Mbps (per the D-PHY specification)
Maximum bit rate (low-power mode)	10 Mbps (per the D-PHY specification)
Minimum bit rate (low-power mode)	800 Kbps (based on timers)
Version support MIPI D-PHY 0.89 , 0.90, 1.00	Complete, except support for slave mode operation. Only operates as a master on the bus

Stimulus	Features
Packet generation	Yes
ECC/CRC automatic calculation	Yes, done by software
DSI video modes	Burst mode, non-burst mode, command mode

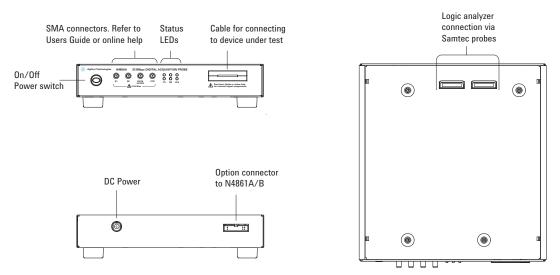
Error injection	
HSDT request error generation	Yes, with timing control to violate specs
SOT synch error generation	No
Endof HSDT error generation	Yes, with timing control to violate specs
LPD transmission error generation	Yes, with waveform timing control and direct control of data transmitted on the link
Protocol errors	Yes
Turnaround error generation	No (does not operate in slave mode)
ECC, CRC error generation	Manual

### N4851A/B and N4861A/B Physical Characteristics

#### **Dimensions**



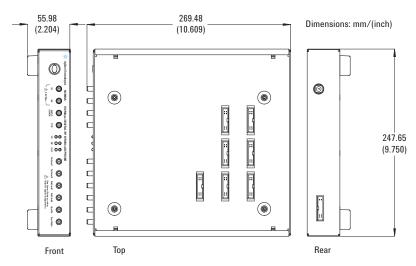
N4851A/B exterior dimensions



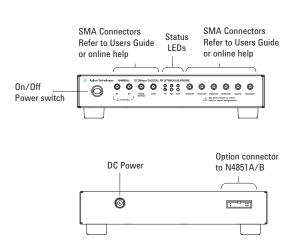
N4851A/B front panel, rear panel and top view

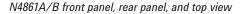
### N4851A/B and N4861A/B Physical Characteristics (continued)

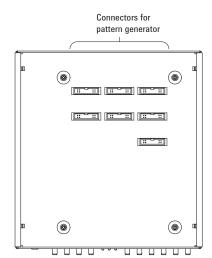
#### **Dimensions**



N4861A/B exterior dimensions







#### **Ordering Information**

When you configure your MIPI D-PHY measurement system, consider the following:

# Ability to provide MIPI D-PHY stimulus

 For comprehensive stimulus and response testing of your MIPI D-PHY device or system, select a logic analyzer with digital pattern generation capability (16822A, 16823A, or a 16900 modular logic analysis system with a 16720A pattern generator module).

# Flexibility to grow as your measurement needs evolve:

 A modular 16900 Series logic analyzer addresses your measurement needs today and allows you to grow as your needs evolve.

# Modification of the logic analyzer's MIPI D-PHY protocol decoder

 The MIPI D-PHY standard provides the flexibility to customize your control structure and data packets for your specific application. With the B4641A protocol development kit, you can modify the logic analyzer's MIPI D-PHY protocol decoder to track your custom solution.

# DUT requirements for use with N4861A/B stimulus probe:

 SMA (m-m) connectors on the target. The number of SMA connectors depends on your test scenario: turn on, validation, or system integration.

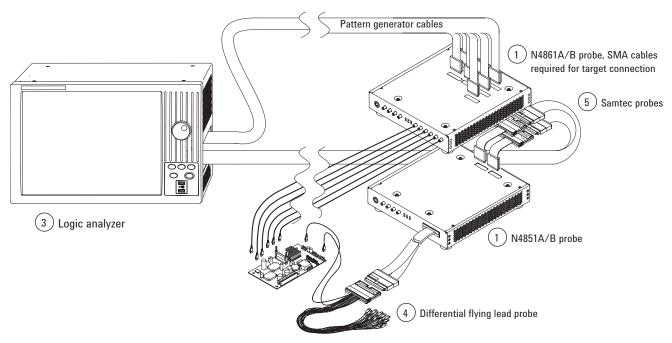
#### N4851U upgrade kit

If you own an N4851A MIPI D-PHY analysis probe or an N4861A MIPI D-PHY stimulus probe, the N4851U upgrade kit will extend the capabilities of your test system:

- With the N4851U-004, your N4851A analysis probe can support up to 4 lanes.
- With the N4851U-004, your N4861A simtulus probe will support up to 3 lanes.
- One N4851U-004 is required for each logic analyzer connected to MIPI D-PHY analysis and stimulus probes.

#### Ordering Information: Analysis and Stimulus Solution

To configure a complete MIPI D-PHY digital acquisition and stimulus system, you will need to order or have the following items:



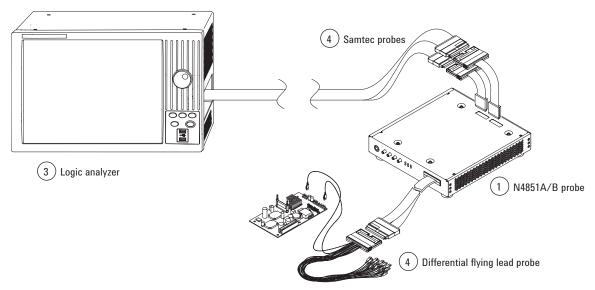
MIPI D-PHY digital acquisition and stimulus system

#### Probes between the N4851A/B and the... 1. MIPI D-PHY probes 3. Logic analyzer with 4. Device under test 2. Method to create 5. Logic analyzer 48-channel pattern data (One of the (Two Samtec generator<sup>2</sup> following for each probes per N4851A/B - one N4851A/B) for Tx and one for Rx. Select probe that is compatible with your logic analyzer.) N4861A or N4861B<sup>1</sup> • E5381A differential E5385A for logic Convert captured 16800 Series portables digital stimulus probe logic analyzer trace 16822A - 68 ch flying lead probe analyzers with N4861A-040: Two sets to stimulus 16823A - 102 ch E5405A differential a 40-pin cable of four 40-inch SMA pro series soft touch connection (16822A, Custom 16900 Series modular probe cables programmatic 16823A, 16910/11A) mainframe with at generation E5387A differential E5378A for logic N4851A digital least one each of the soft touch probe analyzers with acquisition probe following: a 90-pin cable -010 for node-locked · 16900 Series connection (1695X module(s) license modules) · -020 for floating 16720A pattern (server) license generator module N4851B digital acquisition probe

- 1. N4861A/B digital stimulus probe requires an N4851A/B digital acquisition probe to operate and a clock generator, such as the Agilent 33250A.
- 2. Compatible with 16800 or 16900 Series logic analyzers with 68 channels or more.

### Ordering Information: Analysis Solution

To configure a complete MIPI D-PHY digital acquisition system, you will need to order or have the following items:



MIPI D-PHY digital acquisition system

		Probes between the N4851A	/B and the
1. MIPI probes (One per Tx/Rx pair)	2. Logic analyzer <sup>1</sup>	3. Device under test (One of the following for each N4851A/B)	4. Logic analyzer (Two Samtec probes per N4851A/B — one for Tx and one for Rx. Select probe that is compatible with your logic analyzer)
N4851A digital acquisition probe     -010 for node-locked license     -020 for floating (server) license N4851B digital acquisition probe	16800 Series portables  • 16802A – 68 ch  • 16803A – 102 ch  • 16804A – 136 ch  • 16806A – 204 ch  • 16822A – 68 ch  • 16823A – 102 ch  16900 Series modular mainframe with at least one 16900 Series module	<ul> <li>E5381A differential flying lead probe</li> <li>E5405A differential pro series soft touch probe</li> <li>E5387A differential soft touch probe</li> </ul>	<ul> <li>E5385A Samtec probe for logic analyzers with a 40-pin cable connection (16800 Series, 16910/11A)</li> <li>E5378A Samtec probe for logic analyzers with a 90-pin cable connection (1695X modules)</li> </ul>

<sup>1.</sup> Compatible with 16800 or 16900 Series logic analyzers with 68 channels or more

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#### Related Agilent literature

Publication title	Pub number
Agilent 16800 Series Portable Logic Analyzers Data Sheet	5989-5063EN
Agilent 16900 Series Logic Analysis Mainframes Data Sheet	5989-0421EN
Probing Solutions for Agilent Technologies Logic Analyzers Catalog	5968-4632E

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